Notice of References Cited Application/Control No. 10/635,760 Examiner Brian D Nash Applicant(s)/Patent Under Reexamination SEN-MU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,438,449	04-1969	SMITH ARTHUR J	173/17
*	В	US-3,563,438	02-1971	Doyle et al.	227/8
*	С	US-3,584,775	06-1971	Volkmann et al.	227/130
*	D	US-5,181,450	01-1993	Monacelli, Umberto	91/41
*	E	US-6,095,256	08-2000	Lindsay, Steven James	173/115
*	F	US-6,095,394	08-2000	Wang-Kuan, Lin	227/130
*	G	US-6,138,888	10-2000	Liao, Walter	227/130
*	Н	US-6,364,192	04-2002	Lin, Wang-Kuan	227/113
*	1	US-6,488,102	12-2002	Lindsay, Steven James	173/115
*	J	US-6,508,315	01-2003	Lindsay, Steven James	173/115
*	K.	US-6,598,775	07-2003	Chen, Tung-Hsien	227/113
*	L	US-6,691,798	02-2004	Lindsay, Steven James	173/115
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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